

**Notice of References Cited**

Application/Control No.

10/581,429

Applicant(s)/Patent Under

Reexamination

NAITO ET AL.

Examiner

Jack I. Berman

Art Unit

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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N	JP 11-354064	12-1999	Japan	Ogata et al.	
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